





#### **40V N-CHANNEL ENHANCEMENT MODE MOSFET**

#### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub> T <sub>A</sub> = 25°C		
40V	34mΩ @ V <sub>GS</sub> = 10V	7.2A		
400	59mΩ @ V <sub>GS</sub> = 4.5V	5.5A		

### **Description and Applications**

This MOSFET has been designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor control
- Backlighting
- DC-DC Converters
- Power management functions

#### **Features and Benefits**

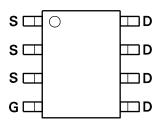
- 100% Unclamped Inductive Switch (UIS) test in production
- Low on-resistance
- Fast switching speed
- Max Q<sub>q</sub> rated
- "Green" component and RoHS compliant (Note 1)
- Qualified to AEC-Q101 Standards for High Reliability

#### **Mechanical Data**

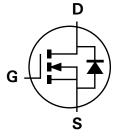
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Copper lead frame.
   Solderable per MIL-STD-202, Method 208
- Weight: 0.074 grams (approximate)







Top View



**Equivalent Circuit** 

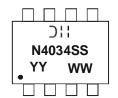
#### **Ordering Information (Note 1)**

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel	
DMN4034SSS-13	N4034SS	13	12	2,500	

1. Diodes, Inc. defines "Green" products as those which are RoHS compliant and contain no halogens or antimony compounds; further information about Diodes Inc.'s "Green" Policy can be found on our website. For packaging details, go to our website.

#### **Marking Information**

Note:



Oll = Manufacturer's Marking N4034SS = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 09 = 2009) WW = Week (01 - 53)





## **Maximum Ratings** @T<sub>A</sub> = 25°C unless otherwise specified

	Characteristic			Value	Unit	
Drain-Source voltage		V <sub>DSS</sub> 40				
Gate-Source voltage		(Note 2)	V <sub>GS</sub>	±20	V	
Single Pulsed Avalanche Er	nergy	(Note 7)	E <sub>AS</sub> 27		mJ	
Single Pulsed Avalanche Current		(Note 7)	I <sub>AS</sub>	15.25	А	
Continuous Drain current		(Note 4)		7.2		
	$V_{GS} = 10V$	$T_A = 70^{\circ}C$ (Note 4)	I <sub>D</sub>	5.8	Α	
		(Note 3)		5.4		
Pulsed Drain current	in current V <sub>GS</sub> = 10V (Note 5)		I <sub>DM</sub>	33.0	Α	
Continuous Source current (	(Body diode)	(Note 4)	Is	4.1	А	
Pulsed Source current (Body diode)		(Note 5)	I <sub>SM</sub>	33.0	A	

### Thermal Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit	
Power dissipation Linear derating factor	(Note 3)	)	1.56 12.5	W
	(Note 4)	P <sub>D</sub>	2.8 22.5	mW/°C
Thermal Desistance Junction to Ambient	(Note 3)	-	80	
Thermal Resistance, Junction to Ambient	(Note 4)	$R_{\thetaJA}$	44.5	°C/W
Thermal Resistance, Junction to Lead	(Note 6)	$R_{ hetaJL}$	37	
Operating and storage temperature range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C

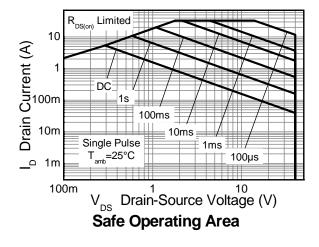
#### Notes:

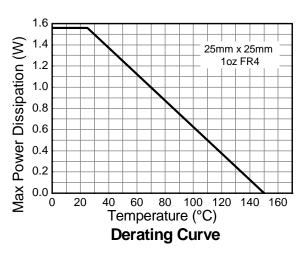
- 2. AEC-Q101  $V_{GS}$  maximum is  $\pm 16V$ .
- 3. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 4. Same as note (3), except the device is measured at  $t \le 10$  sec.
- 5. Same as note (3), except the device is pulsed with D = 0.02 and pulse width 300µs. The pulse current is limited by the maximum junction temperature.

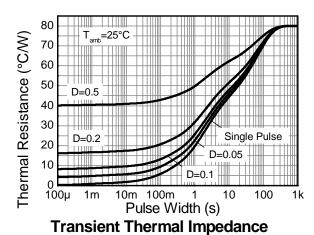
  6. Thermal resistance from junction to solder-point (at the end of the drain lead).
- 7. UIS in production with L =  $100\mu$ H,  $V_{DD} = 40$ V.

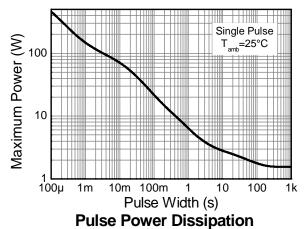


### **Thermal Characteristics**













## Electrical Characteristics @T<sub>A</sub> = 25°C unless otherwise specified

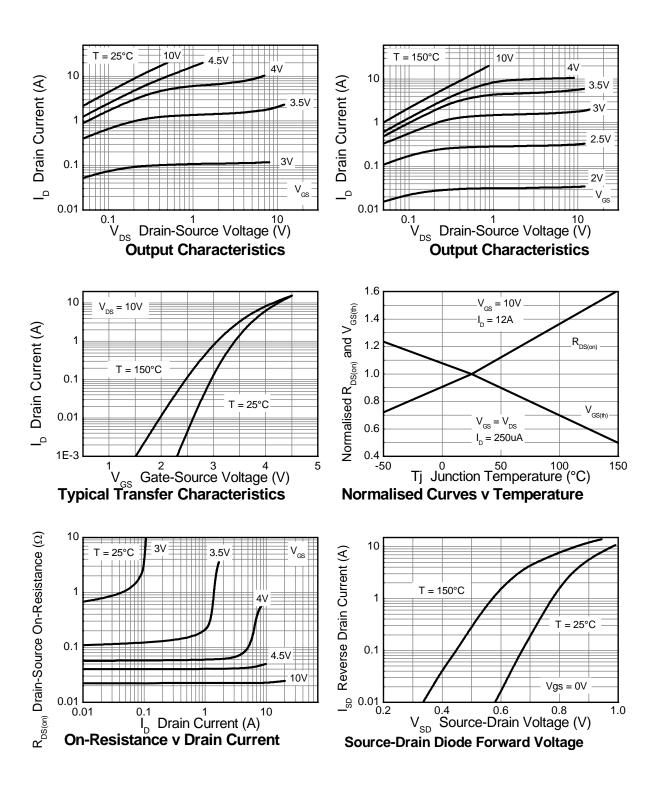
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	40	_	_	V	$I_D = 250 \mu A, V_{GS} = 0 V$		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 40V, V_{GS} = 0V$		
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$		
ON CHARACTERISTICS								
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.0	_	3.0	V	$I_D = 250 \mu A, V_{DS} = V_{GS}$		
Static Drain Source On Registence (Note 9)	5		0.023	0.034	0	V <sub>GS</sub> = 10V, I <sub>D</sub> = 6A		
Static Drain-Source On-Resistance (Note 8)	R <sub>DS (ON)</sub>	_	0.039	0.059	Ω	$V_{GS} = 4.5V, I_D = 5A$		
Forward Transconductance (Notes 8 & 9)	<b>g</b> fs	_	20.5	_	S	V <sub>DS</sub> = 15V, I <sub>D</sub> = 6A		
Diode Forward Voltage (Note 8)	V <sub>SD</sub>	_	0.87	1.1	V	$I_{S} = 6A, V_{GS} = 0V$		
Reverse recovery time (Note 9)	t <sub>rr</sub>		11.9	_	ns	0.54 11/11 4004/		
Reverse recovery charge (Note 9)	Q <sub>rr</sub>	_	4.9	_	nC	I <sub>S</sub> = 2.5A, di/dt = 100A/μs		
DYNAMIC CHARACTERISTICS (Note 9)				•	•	•		
Input Capacitance	C <sub>iss</sub>	_	453	_	pF			
Output Capacitance	Coss	_	79.1	_	pF	$V_{DS} = 20V, V_{GS} = 0V$ f = 1MHz		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	40.5	_	pF	1 - 11/11/12		
Total Gate Charge (Note 10)	Qg	_	4.9	8	nC	V <sub>GS</sub> = 4.5V		
Total Gate Charge (Note 10)	Qg	_	10	18	nC	V <sub>DS</sub> = 20V		
Gate-Source Charge (Note 10)	Q <sub>gs</sub>	_	1.8	_	nC	$V_{GS} = 10V$ $I_D = 6A$		
Gate-Drain Charge (Note 10)	Q <sub>gd</sub>	_	2.4	_	nC			
Turn-On Delay Time (Note 10)	t <sub>D(on)</sub>	_	2.7	_	ns	·		
Turn-On Rise Time (Note 10)	t <sub>r</sub>	_	2.7	_	ns	$V_{DD} = 20V, V_{GS} = 10V$		
Turn-Off Delay Time (Note 10)	t <sub>D(off)</sub>	_	14	_	ns	$I_D = 1A, R_G \cong 6.0\Omega$		
Turn-Off Fall Time (Note 10)	t <sub>f</sub>	_	6	_	ns			

Notes:

<sup>8.</sup> Measured under pulsed conditions. Pulse width ≤ 300µs; duty cycle ≤ 2%
9. For design aid only, not subject to production testing.
10. Switching characteristics are independent of operating junction temperatures.

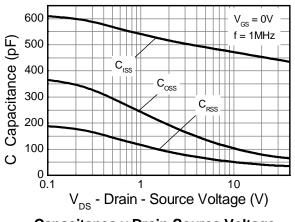


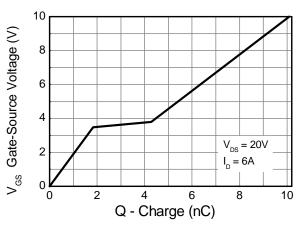
### **Typical Characteristics**





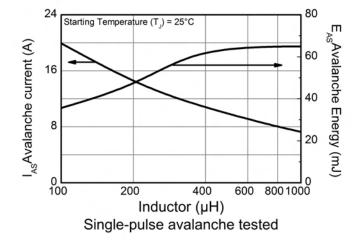
## **Typical Characteristics – continued**





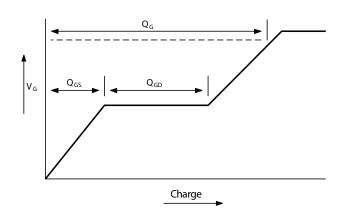
Capacitance v Drain-Source Voltage

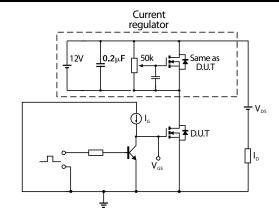
**Gate-Source Voltage v Gate Charge** 





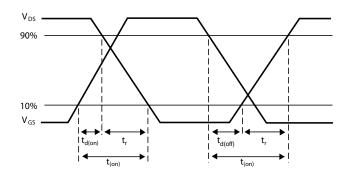
## **Test Circuits**

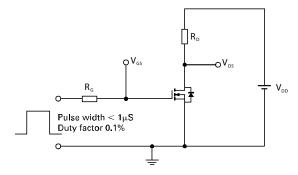




Basic gate charge waveform

Gate charge test circuit



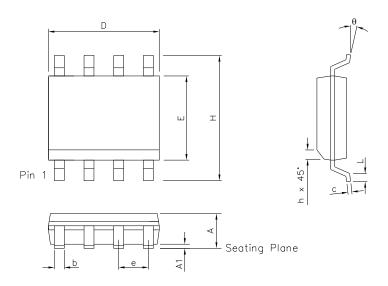


Switching time waveforms

Switching time test circuit

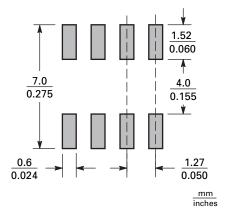


# **Package Outline Dimensions**



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	θ	0°	8°	0°	8°
Е	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-		-

# **Suggested Pad Layout**







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